

Additional modeling comparing Hamamatsu and Broadcom SiPM for HEP PWO readout

Consider 15, 20, 25, 30% optical coupling efficiency between PWO and SiPM to estimate non-linearity

Modeling computation (energy linearity)

- Estimate the number of cells firing from incident particle
- Compute integral non-linearity at 15GeV
- Photon collection from crystal to SiPM? Use 100% and 20% (more realistic)

$$N_{\text{fired}}(M, V, \lambda) = M \cdot \left\{ 1 - \exp \left[- \frac{PDE(V, \lambda) \cdot N_{ph}}{M} \right] \right\}$$

N_{fired} = number of activated cells

M = total number of cells

$PDE(V, \lambda)$ = photodetection efficiency

V = bias voltage, λ = photon wavelength

N_{ph} = number of incident photons

| | Hamamatsu S14160-3010 | Onsemi 60035 | Hamamatsu S14160-3015 | Broadcom AFBR-S4N44C013 | Broadcom AFBR-S4N44P014M |
|---|-----------------------|--------------|-----------------------|-------------------------|--------------------------|
| Total number of cells | 89984 | 22292 | 39984 | 15060 | 8334 |
| Incoming Particle energy (eV) | 1.50E+10 | 1.50E+10 | 0 | 1.50E+10 | 1.50E+10 |
| Scintillator light yield (ph/eV) | 1.50E-05 | 1.50E-05 | 1.50E-05 | 1.50E-05 | 1.50E-05 |
| N photon / incoming particle | 2.25E+05 | 2.25E+05 | 5 | 2.25E+05 | 2.25E+05 |
| Crystal surface area (mm ²) | 400 | 400 | 400 | 400 | 400 |
| Nflux (ph/mm ²) | 563 | 563 | 563 | 563 | 563 |
| Nb of SiPM | 16 | 9 | 16 | 16/25 | 16 |
| SiPM active area (mm ²) | 9 | 37 | 9 | 13.84 | 13.47 |
| Nph for one SiPM | 5063 | 20725 | 5063 | 7784.1 | 7575 |
| Include fill factor to Nph | 1569 | 15544 | 2481 | 4687 | 5757 |
| Nb of activated sites/SiPM | 907 | 6635 | 1588 | 3001 | 3633 |
| INL at 15GeV | 0.18% | 10.69% | 1.26% | 8.21% | 24% |
| Total activated cells | 14506 | 59713 | 25402 | 48021 | 58131 |
| Resolution (bit) | 14 | 16 | 15 | 16 | 16 |
| INL at 15GeV 20% coupling efficiency | 0.04% | 2.56% | 0.26% | 1.85% | 6.59% |
| Total activated cells | 2913 | 13687 | 5163 | 10476 | 14428 |
| Resolution (bit) | 12 | 14 | 13 | 14 | 14 |

Best compromises

Additional NL estimates vs. optical coupling

| | Hamamatsu S14160-3010 | Onsemi 60035 | Hamamatsu S14160-3015 | Broadcom AFBR- S4N44C013 | Broadcom AFBR- S4N44P014M |
|---------------------------------------|--------------------------|-----------------|--------------------------|--------------------------------|---------------------------------|
| Total number of cells | 89984 | 22292 | 39984 | 15060 | 8334 |
| Nb of SiPM | 16 | 9 | 16 | 16/25 | 16 |
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| Nph for one SiPM | 5063 | 20725 | 5063 | 7784.1 | 7575 |
| Include fill factor to Nph | 1569 | 15544 | 2481 | 4687 | 5757 |
| Nb of activated sites/SiPM | 907 | 6635 | 1588 | 3001 | 3633 |
| INL at 15GeV 100% coupling efficiency | 0.5% | 15.8% | 2.0% | 10.33% | 24% |
| Total activated cells | 14506 | 59713 | 25402 | 48021 | 58131 |
| Resolution (bit) | 14 | 16 | 15 | 16 | 16 |
| INL at 15GeV 15% coupling efficiency | 0.08% | 2.6% | 0.30% | 1.65% | 4.17% |
| Total activated cells | 2185 | 10355 | 3876 | 7900 | 10975 |
| Resolution (bit) | 12 | 14 | 12 | 13 | 14 |
| INL at 15GeV 20% coupling efficiency | 0.10% | 3.45% | 0.40% | 2.19% | 5.51% |
| Total activated cells | 2913 | 13687 | 5163 | 10476 | 14428 |
| Resolution (bit) | 12 | 14 | 13 | 14 | 14 |
| INL at 15GeV 25% coupling efficiency | 0.13% | 4.29% | 0.50% | 2.73% | 6.83% |
| Total activated cells | 3640 | 16960 | 6447 | 13023 | 17785 |
| Resolution (bit) | 12 | 15 | 13 | 14 | 15 |
| INL at 15GeV 30% coupling efficiency | 0.15% | 5.12% | 0.61% | 3.26% | 8.12% |
| Total activated cells | 4367 | 20176 | 7729 | 15542 | 21047 |
| Resolution (bit) | 13 | 15 | 13 | 14 | 15 |

| | |
|---|----------|
| Incoming Particle energy (eV) | 1.50E+10 |
| Scintillator light yield (ph/eV) | 1.50E-05 |
| N photon / incoming particle | 2.25E+05 |
| Crystal surface area (mm ²) | 400 |
| Nflux (ph/mm ²) | 563 |

$$N_{\text{fired}}(M, V, \lambda) = M \cdot \left\{ 1 - \exp \left[- \frac{PDE(V, \lambda) \cdot N_{\text{ph}}}{M} \right] \right\}$$

$$INL = \left(\frac{PDE(V, \lambda) \cdot N_{\text{ph}} - N_{\text{fired}}}{PDE(V, \lambda) \cdot N_{\text{ph}}} \right)$$

N_{fired} = number of activated cells

M = total number of cells

$PDE(V, \lambda)$ = photodetection efficiency

V = bias voltage, λ = photon wavelength

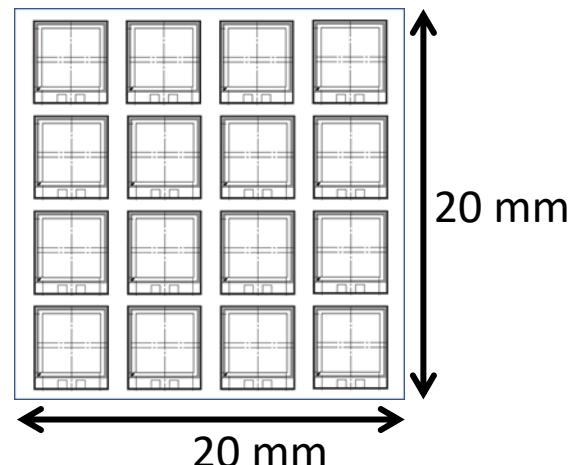
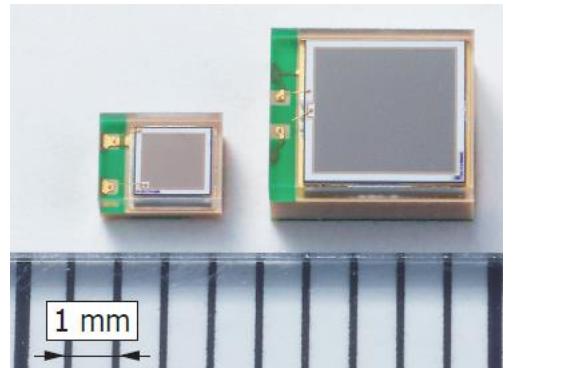
N_{ph} = number of incident photons

Hamamatsu S14160-3015

- 3 mm x 3 mm active
- PDE 32% (at 420 nm)
- 15 μm microcells
- Anode capacitance 530 pF
- Dark count rate 700kcps (typ.)
- VOP variation within reel $\pm 0.1\text{V}$ ($\pm 8\%$ gain)

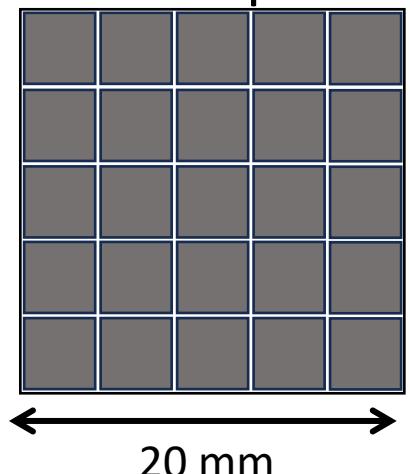
- 16 pcs to fill 20 mm x 20 mm
- Active fill: 36% of area
- Rough computation for # activated cells for 15GeV deposited in crystal: 5,160 (20% coupling eff.)
- Expected Integral Non-linearity at 15GeV: 0.40% (20% coupling eff.)
- Measured fast timing (70ns FWHM)

16 x 3015



Broadcom AFBR-S4N44C013

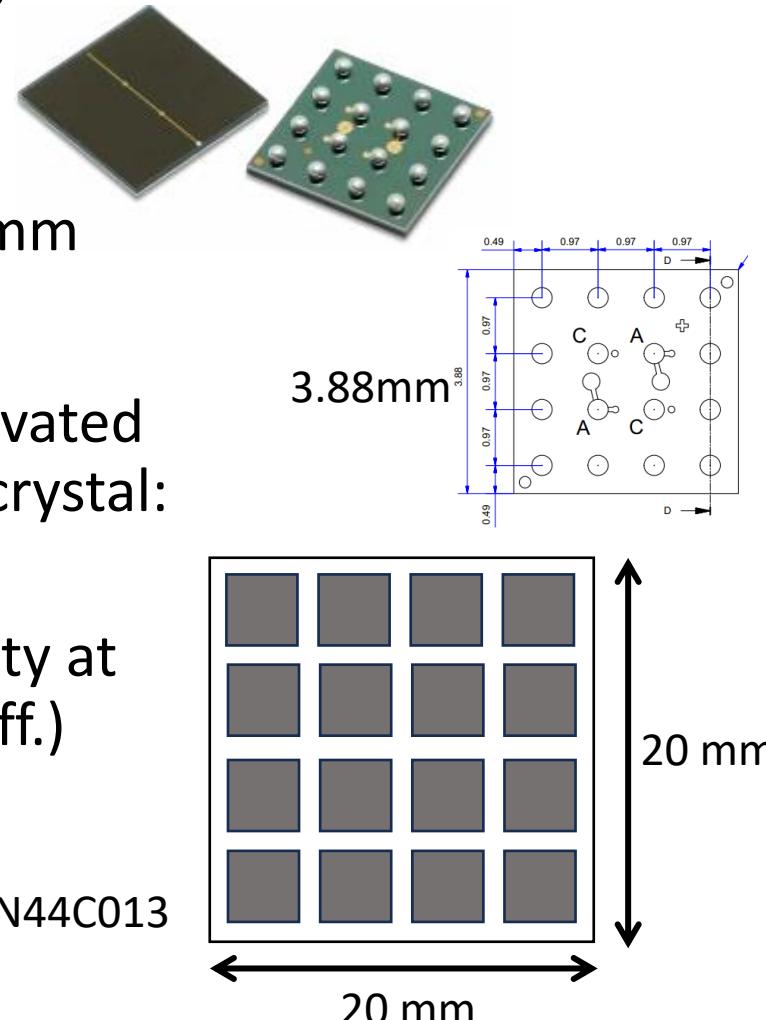
- 3.72 mm x 3.72 mm active
- PDE 43/55% (420 nm) (typ./perf.)
- 30 µm microcells
- Anode capacitance 990/760 pF (typ./perf.) slightly longer pulse
- Dark count rate 1660 kcps (typ.)



20 mm

5x5 matrix for area coverage is possible
86% active coverage (better than PMT)

- 16/25 pcs to fill 20 mm x 20 mm
- Active fill: 55/86% of area
- Rough computation for # activated cells for 15GeV deposited in crystal: 10,476 (20% coupling eff.)
- Expected Integral Non-linearity at 15GeV: 2.2% (20% coupling eff.)



Expected resolution with different SiPMs

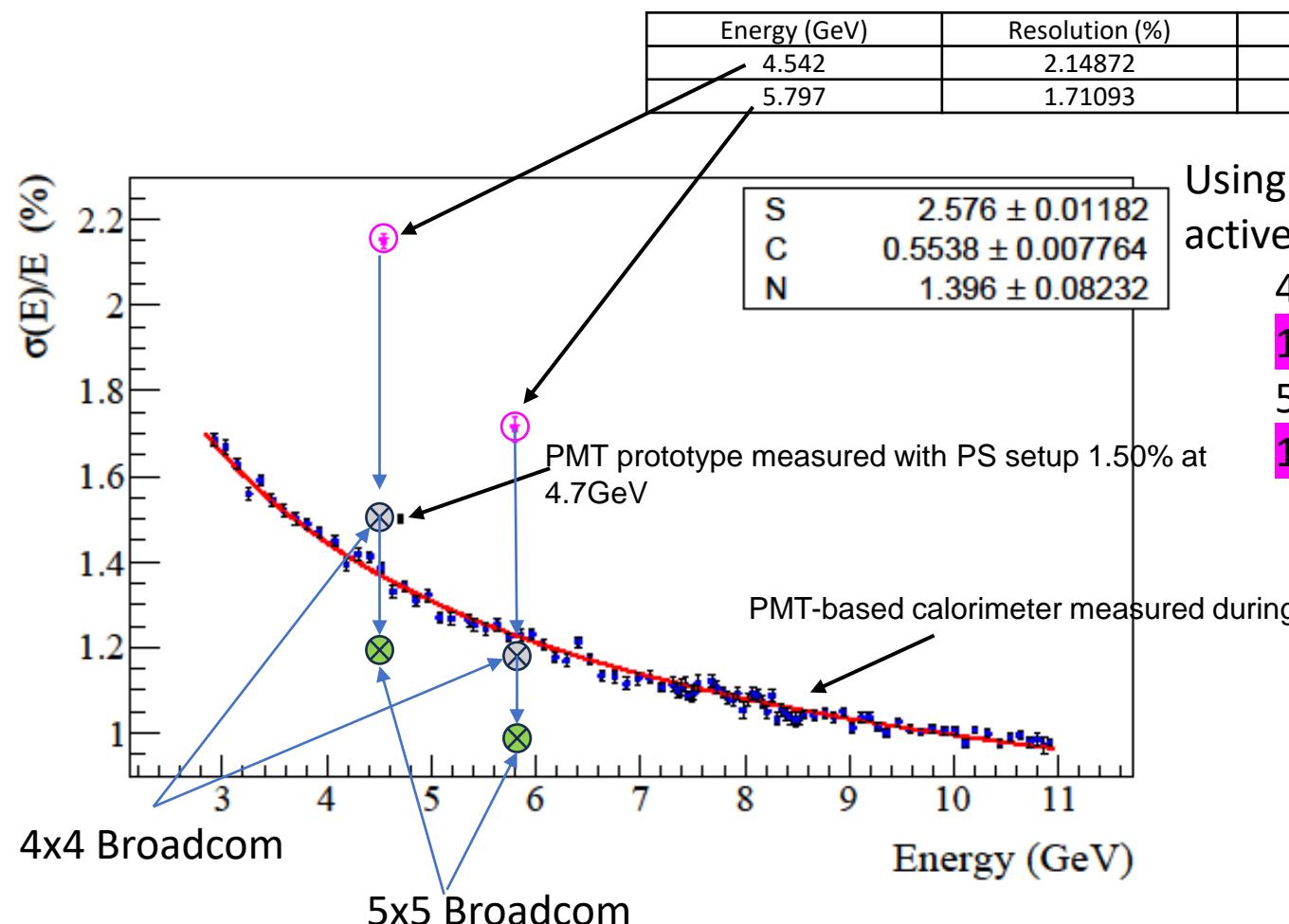
- Use measured resolution from experiment as reference
- Compute relative signal level from change in PDE and active area
- Compute resolution change (1rst order scales with square root of signal)

| | Hamamatsu 14160-3010 | Hamamatsu 14160-3015 | Hamamatsu 14160-6015 | Hamamatsu 14160-6010 | Broadcom AFBR-S4N44C013 | Broadcom AFBR-S4N44C013 | Broadcom AFBR-S4N44P014M | PMT Hamamatsu R4125 (19mm dia, 15mm cathode) |
|---|-------------------------|-------------------------|-------------------------|-------------------------|-------------------------|-------------------------|--------------------------|--|
| configuration | 4x4 | 4x4 | 2x2 | 2x2 | 4x4 | 5x5 | 4x4 | 1 |
| PDE (% 420nm) | 17 | 30 | 30 | 17 | 43 | 43 | 63 | 27 |
| active fill (%) | 36 | 36 | 36 | 36 | 55 | 86 | 54 | 71 |
| relative signal level (100%) | 57 | 100 | 100 | 57 | 219 | 342 | 314 | 177 |
| expected resolution at 4.54 GeV (%) | 2.86 | 2.15 | 2.15 | 2.86 | 1.45 | 1.16 | 1.21 | 1.62 |
| expected resolution at 5.8 GeV (%) | 2.27 | 1.71 | 1.71 | 2.27 | 1.16 | 0.92 | 0.96 | 1.28 |

Measured at JLab w. 3x3 Crytur prototype 2.0 predicted

Predicted PMT resolution:
1.59% at 4.7GeV
 Measurement: **1.5%**
 3x3 PMT based detector
 measured at JLAB

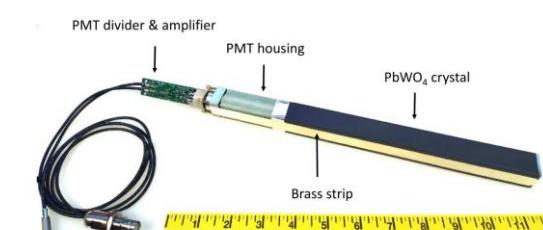
Energy resolution: comparison with PMT



Using Broadcom AFBR-S4N44C013 w. higher PDE and active area

4x4 array res. 4.54 GeV 2.15% \rightarrow 1.45%; 5.8 GeV
1.71% \rightarrow 1.16%

5x5 array res. 4.54 GeV 2.15% \rightarrow 1.16%; 5.8 GeV
1.71% \rightarrow 0.92%



Hamamatsu 4125

Summary table

| | Hamamatsu 14160-3010 | Hamamatsu 14160-3015 | Hamamatsu 14160-6015 | Hamamatsu 14160-6010 | Broadcom AFBR- S4N44C013 | Broadcom AFBR- S4N44C013 | Broadcom AFBR- S4N44P014M | PMT Hamamatsu R4125 (19mm dia, 15mm cathode) |
|---|-------------------------|-------------------------|-------------------------|-------------------------|-----------------------------|-----------------------------|------------------------------|--|
| Cell pitch (μm) | 10 | 15 | 15 | 10 | 30 | 30 | 40 | 15000 |
| Capacitance (pF) | 530 | 530 | 2500 | 2500 | 990/760 | 990/760 | 580 | |
| PDE at 420nm (%) | 17 | 30 | 30 | 30 | 43/55 | 43/55 | 63 | 27 |
| configuration | 4x4 | 4x4 | 2x2 | 2x2 | 4x4 | 5x5 | 4x4 | 1 |
| PDE (% 420nm) | 17 | 30 | 30 | 17 | 43 | 43 | 63 | 27 |
| active fill (%) | 36 | 36 | 36 | 36 | 55 | 86 | 54 | 71 |
| relative signal level (100%) | 57 | 100 | 100 | 57 | 219 | 342 | 314 | 177 |
| expected resolution at 4.54 GeV (%) | 2.86 | 2.15 | 2.15 | 2.86 | 1.45 | 1.16 | 1.21 | 1.62 |
| expected resolution at 5.8 GeV (%) | 2.27 | 1.71 | 1.71 | 2.27 | 1.16 | 0.92 | 0.96 | 1.28 |

PMT: 1.59% at 4.7GeV
Measurement: 1.5%

Significant resolution improvement, slight pulse timing and NL tradeoff

Response linearity check, peak position vs beam energy

